

## Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Report No: CCISE190801101V01

# **FCC REPORT**

(WCDMA)

Applicant: Lightcomm Technology Co., Ltd.

Address of Applicant: UNIT 1306 13/F ARION COMMERCIAL CENTRE, 2-12

QUEEN'S ROAD WEST, SHEUNG WAN HK

**Equipment Under Test (EUT)** 

Product Name: TABLET

Model No.: MID7003-ML, SM7216H, SchokMini7HC, DL722G

FCC ID: XMF-MID7003

FCC CFR Title 47 Part 2

**Applicable standards:** FCC CFR Title 47 Part 22 Subpart H FCC CFR Title 47 Part 24 Subpart E

FCC CFR Title 47 Part 27 Subpart L

Date of sample receipt: 07 Aug., 2019

**Date of Test:** 08 Aug., to 29 Aug., 2019

Date of report issued: 25 Oct., 2019

Test Result: PASS\*

\* In the configuration tested, the EUT complied with the standards specified above.

#### Authorized Signature:



Bruce Zhang Laboratory Manager

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product and does not permit the use of the CCIS product certification mark. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

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### 2. Version

Version No.	Date	Description
00	02 Sep., 2019	Original
01	25 Oct., 2019	Updated Page 30~32

Test Engineer

Reviewed by: Date: 25 Oct., 2019

Project Engineer



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4. Test Summary

Test Item	Section in CFR 47	Result
RF Exposure (SAR)	Part 1.1307 Part 2.1093	Pass (Please refer to SAR Report)
RF Output Power	Part 2.1046 Part 22.913 (a)(5) Part 24.232 (c) Part 27.50 (d)(4)	Pass
Peak-to-Average Power Ratio	Part 24.232 (d) Part 27.50(d)(5)	Pass
Modulation Characteristics	Part 2.1047	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049 Part 22.917(b) Part 24.238(b) Part 27.53(h)	Pass
Out of band emission at antenna terminals	Part 2.1053 Part 22.917 (a) Part 24.238 (a) Part 27.53 (h)	Pass
Field strength of spurious radiation	Part 22.917 (a) Part 24.238 (a) Part 27.53 (h)	Pass
Frequency stability vs. temperature	Part 22.355 Part 24.235 Part 27.54 Part 2.1055(a)(1)(b)	Pass
Frequency stability vs. voltage	Part 22.355 Part 24.235 Part 27.54 Part 2.1055(d)(2)	Pass





## 5. General Information

### **5.1 Client Information**

Applicant:	Lightcomm Technology Co., Ltd.	
Address:	UNIT 1306 13/F ARION COMMERCIAL CENTRE, 2-12 QUEEN'S ROAD WEST, SHEUNG WAN HK	
Manufacturer/ Factory:	Huizhou Hengdu Electronics Co., Ltd.	
Address:	No.8 Huitai Road, Huinan High-tech Industrial Park, Huiao Avenue, Huizhou, Guangdong, China	

## 5.2 General Description of E.U.T.

Product Name:	TABLET
Model No.:	MID7003-ML, SM7216H, SchokMini7HC, DL722G
Operation Frequency range:	WCDMA Band V: 826.4MHz-846.6MHz
	WCDMA Band II: 1852.4 MHz-1907.6 MHz
	WCDMA Band IV: 1712.4 MHz-1752.6 MHz
Modulation type:	UMTS: QPSK
Antenna type:	Internal Antenna
Antenna gain:	WCDMA Band V: -3.42 dBi
	WCDMA Band II: 2.11 dBi
	WCDMA Band IV: 1.45 dBi
Power supply:	Rechargeable Li-ion Battery DC3.7V, 2700mAh
AC adapter:	Model: TEKA006-0501500UKU
	Input: AC100-240V, 50/60Hz, 0.3A
	Output: DC 5V, 1.5A
Test Sample Condition:	The test samples were provided in good working order with no visible defects.
Remark:	The No.: MID7003-ML, SM7216H, SchokMini7HC, DL722G were identical inside, the electrical circuit design, layout, components used and internal wiring, with only difference being model name.





**Operation Frequency List:** 

WCDM	1A Band V	WCDN	/IA Band II
Channel	Channel Frequency (MHz)		Frequency (MHz)
4132	4132 826.40		1852.40
4133	826.60	9263	1852.60
4182	836.40	9399	1879.80
4183	836.60	9400	1880.00
4184	836.80	9401	1880.20
4232	846.40	9537	1907.40
4233	4233 846.60		1907.60
WCDM	IA Band IV		
Channel	Channel Frequency (MHz)		
1312	1712.40		
1313	1712.60		
1412	1732.40		
1413	1732.60		
1414	1732.80		
1512	1752.40		
1513	1752.60		

Regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

	WCDMA Band \	V	WCDMA Band II			
Chanr	Channel		Channel		Frequency(MHz)	
Lowest	4132	826.40	Lowest	9262	1852.40	
Middle	4183	836.60	Middle	9400	1880.00	
Highest	Highest 4233		Highest	9538	1907.60	
	WCDMA Band I	V				
Channel		Frequency(MHz)				
Lowest	1312	1712.40				
Middle 1413		1732.60				
Highest 1513		1752.60				



### 5.3 Test modes

Operating Environment	Operating Environment:			
Temperature:	Normal: 15°C ~ 35°C, Extreme: -30°C ~ +50°C			
Humidity:	20 % ~ 75 % RH			
Atmospheric Pressure:	1008 mbar			
Voltage:	Nominal: 3.7Vdc, Extreme: Low 3.5 Vdc, High 4.20 Vdc			
Test mode:	Test mode:			
RMC mode	Keep the EUT communication with simulated station in RMC mode			
HSDPA	Keep the EUT communication with simulated station in HSDPA mode			
HSUPA	Keep the EUT communication with simulated station in HSUPA mode			

Remark: The EUT has been tested under continuous transmitting mode. Channel Low, Mid and High for each type band with rated data rate were chosen for full testing. The field strength of spurious radiation emission was measured as EUT stand-up position (H mode) and lie down position (E1, E2 mode) for these modes with power adaptor, earphone and Data cable. Just the worst case position (H mode) shown in report.

### 5.4 Description of Support Units

Test Equipment	Manufacturer	Model No.	Serial No.
Simulated Station	Anritsu	MT8820C	6201026545

### 5.5 Measurement Uncertainty

Parameters	Expanded Uncertainty
Radiated Emission (9kHz ~ 30MHz)	±3.12 dB (k=2)
Radiated Emission (30MHz ~ 1000MHz)	±4.32 dB (k=2)
Radiated Emission (1GHz ~ 18GHz)	±5.38 dB (k=2)
Radiated Emission (18GHz ~ 40GHz)	±3.36 dB (k=2)

### 5.6 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

#### FCC - Designation No.: CN1211

Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been accredited as a testing laboratory by FCC(Federal Communications Commission). The test firm Registration No. is 727551.

#### ISED – CAB identifier.: CN0021

The 3m Semi-anechoic chamber of Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 10106A-1.

#### CNAS - Registration No.: CNAS L6048

Shenzhen Zhongjian Nanfang Testing Co., Ltd. is accredited to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L6048.

#### A2LA - Registration No.: 4346.01

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General requirements for the competence of testing and calibration laboratories. The test scope can be found as below link: https://portal.a2la.org/scopepdf/4346-01.pdf

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### 5.7 Laboratory Location

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Address: No. B-C, 1/F., Building 2, Laodong No.2 Industrial Park, Xixiang Road,

Bao'an District, Shenzhen, Guangdong, China Tel: +86-755-23118282, Fax: +86-755-23116366

Email: info@ccis-cb.com, Website: http://www.ccis-cb.com

### 5.8 Test Instruments list

Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
3m SAC	SAEMC	9m*6m*6m	966	07-22-2017	07-21-2020
BiConiLog Antenna	SCHWARZBECK	VULB9163	497	03-18-2019	03-17-2020
Biconical Antenna	SCHWARZBECK	VUBA9117	359	06-22-2017	06-21-2020
Horn Antenna	SCHWARZBECK	BBHA9120D	916	03-18-2019	03-17-2020
Horn Antenna	SCHWARZBECK	BBHA9120D	1805	06-22-2017	06-21-2020
Horn Antenna	SCHWARZBECK	BBHA 9170	BBHA9170582	11-21-2018	11-20-2019
EMI Test Software	AUDIX	E3	\	/ersion: 6.110919l	)
Pre-amplifier	HP	8447D	2944A09358	03-18-2019	03-17-2020
Pre-amplifier	CD	PAP-1G18	11804	03-18-2019	03-17-2020
Spectrum analyzer	Rohde & Schwarz	FSP30	101454	03-18-2019	03-17-2020
Spectrum analyzer	Rohde & Schwarz	FSP40	100363	11-21-2018	11-20-2019
EMI Test Receiver	Rohde & Schwarz	ESRP7	101070	03-18-2019	03-17-2020
Spectrum Analyzer	Agilent	N9020A	MY50510123	11-10-2018	11-09-2019
Signal Generator	Rohde & Schwarz	SMX	835454/016	03-18-2019	03-17-2020
Signal Generator	R&S	SMR20	1008100050	03-18-2019	03-17-2020
RF Switch Unit	MWRFTEST	MW200	N/A	N/A	N/A
Test Software	MWRFTEST	MTS8200		Version: 2.0.0.0	
Cable	ZDECL	Z108-NJ-NJ-81	1608458	03-18-2019	03-17-2020
Cable	MICRO-COAX	MFR64639	K10742-5	03-18-2019	03-17-2020
Cable	SUHNER	SUCOFLEX100	58193/4PE	03-18-2019	03-17-2020
DC Power Supply	XinNuoEr	WYK-10020K	1409050110020	10-31-2018	10-30-2019
Temperature Humidity Chamber	HengPu	HPGDS-500	20140828008	09-24-2018	09-23-2019
Simulated Station	Rohde & Schwarz	CMW500	140493	07-16-2018	07-15-2019



### 6. Test results

## 6.1 Conducted Output Power, ERP and EIRP

Test Requirement:	FCC part 22.913(a)(5), FCC part 24.232(c), FCC part 27.50(d)(4)		
Test Method:	ANSI/TIA-603-D 2010		
Limit:	WCDMA Band V: 7W, WCDMA Band II: 2W, WCDMA Band IV: 1W		
Test setup:	System simulator ATT EUT		
Test Procedure:	The transmitter output was connected to a calibrated attenuator, the other end of which was connected to the simulated station. Transmitter output power was read off in dBm.		
Test Instruments:	Refer to section 5.8 for details		
Test mode:	Refer to section 5.3 for details		
Test results:	Passed		





### **Measurement Data:**

		Burst Average power (dBm)		
EUT Mode		4132	4183	4233
		826.40 (MHz) 836.60 (MHz) 846.60		846.60 (MHz)
	Subtest 1	23.06	23.34	23.20
UMTS 850	Subtest 2	22.70	22.83	22.76
HSDPA	Subtest 3	21.08	21.35	21.30
	Subtest 4	21.10	21.33	21.32
	Subtest 1	22.55	22.82	22.70
LIMTO OCO	Subtest 2	otest 2 23.00 23.22	23.10	
UMTS 850	Subtest 3	20.68	20.88	20.80
HSUPA	Subtest 4	22.97	23.30	23.18
	Subtest 5	21.65	21.81	21.72
UMTS 850 RMC	12.2kbps	24.00	24.20	24.15
UMTS 850 AMR	UMTS 850 AMR 12.2kbps		24.12	24.08
Antenna Gain (dBi)		-3.42		
Max. ERP (dBm)		18.63		
ERP Limit (dBm	n)	38.45		

		Burst Average power (dBm)		
EUT Mode	EUT Mode		9400	9538
		1852.40 (MHz) 1880.00 (MHz) 1907.60 (		1907.60 (MHz)
	Subtest 1	23.41	23.16	22.94
UMTS 1900	Subtest 2	Jubtest 1     23.41     23.16       Jubtest 2     22.98     22.78       Jubtest 3     21.59     21.35       Jubtest 4     21.44     21.22       Jubtest 1     22.96     22.75       Jubtest 2     23.32     23.05       Jubtest 3     21.05     20.78       Jubtest 4     23.37     23.14       Jubtest 5     22.03     21.79       2.2kbps     24.42     24.15       2.2kbps     24.21     23.92       2.11	22.49	
HSDPA	Subtest 3	21.59	21.35	21.01
	Subtest 4	21.44	21.22	21.00
	Subtest 1	22.96	22.75	22.46
LINATO 4000	Subtest 2	23.32	23.32 23.05	22.88
UMTS 1900	Subtest 3	21.05	20.78	20.46
HSUPA	Subtest 4	23.37	23.14	22.90
	Subtest 5	22.03	21.79	21.48
UMTS 1900 RMC	12.2kbps	24.42	24.15	24.19
UMTS 1900 AMR 12.2kbps		24.21	23.92	23.76
Antenna Gain (dBi)		2.11		
Max. EIRP (dBm)		26.53		
EIRP Limit (dBr	m)	33.00		

Note: EIRP (dBm) = Burst Average power (dBm) + Antenna Gain (dBi). ERP (dBm) = EIRP (dBm) - 2.15 (dB).



EUT Mode		Burst Average power (dBm)		
		1312	1412	1513
		1712.40 (MHz)	1732.40 (MHz)	1752.60 (MHz)
	Subtest 1	22.57	22.77	22.95
UMTS 1700	Subtest 2	22.17	22.41	22.40
HSDPA	Subtest 3	20.66	20.86	20.89
	Subtest 4	20.59	20.92	20.82
	Subtest 1	22.01	22.20	22.36
LIMTO 4700	Subtest 2	22.48	22.70	22.76
UMTS 1700	Subtest 3	20.14	20.25	20.42
HSUPA	Subtest 4	22.52	22.73	22.92
	Subtest 5	21.17	21.35	21.44
UMTS 1700 RMC	12.2kbps	23.46	23.68	23.18
UMTS 1700 AMR	12.2kbps	23.43	23.61	23.13
Antenna Gain (dBi)		1.45		
Max. EIRP (dBm)		25.13		
EIRP Limit (dE	Bm)	30.00		
Note: EIRP (dBm) = Burst Average power	(dBm) + Antenna Gain (dBi).	_	_	



## 6.2 Peak-to-Average Power Ratio

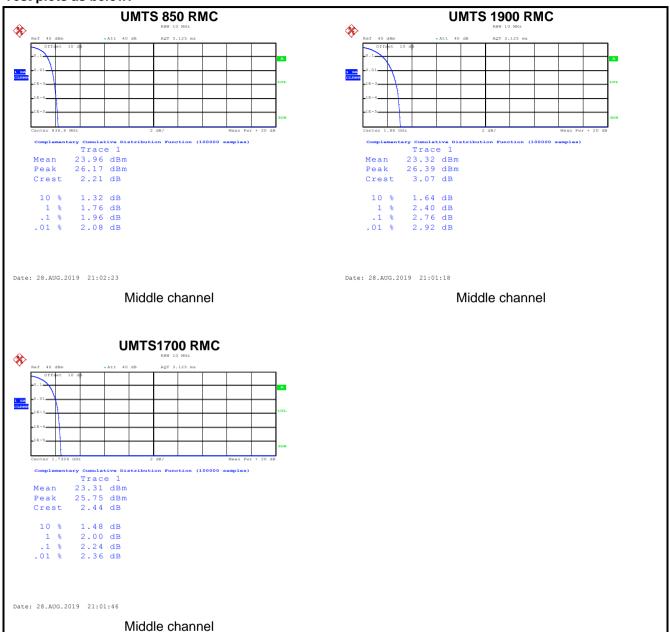
Test Requirement:	FCC part 24.232(d), FCC part 27.50(d)(5)
Test Method	ANSI/TIA-603-D 2010
Limit:	The peak-to-average ratio (PAR) of the transmission may not exceed 13 dB.
Test setup:	System simulator
	Splitter ATT EUT
	Spectrum Analyzer
Test Procedure:	1 The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation.
	<ul><li>2 Set the CCDF option in spectrum analyzer, RBW ≥ OBW,</li></ul>
	3 Set the EUT working in highest power level, measured and recorded the 0.1% as PAPR level.
	4 Repeat step 1~3 at other frequency and modulations.
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed

### **Measurement Data:**

Modulation	Test channel	PAPR
UMTS 850 RMC	4183	1.96
UMTS 1900 RMC	9400	2.76
UMTS1700 RMC	1413	2.24



### Test plots as below:





### 6.3 Occupy Bandwidth

Test Requirement:	FCC part 22.917(b), FCC part 24.238(b), FCC Part 27.53(h)
Test Method:	ANSI/TIA-603-D 2010
Test setup:	System simulator Spectrum Analyzer
Test Procedure:	<ol> <li>The EUT's output RF connector was connected with a short cable to the spectrum analyzer</li> <li>RBW was set to about 1% of emission BW, VBW= 3 times RBW.</li> <li>-26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.</li> </ol>
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





#### **Measurement Data:**

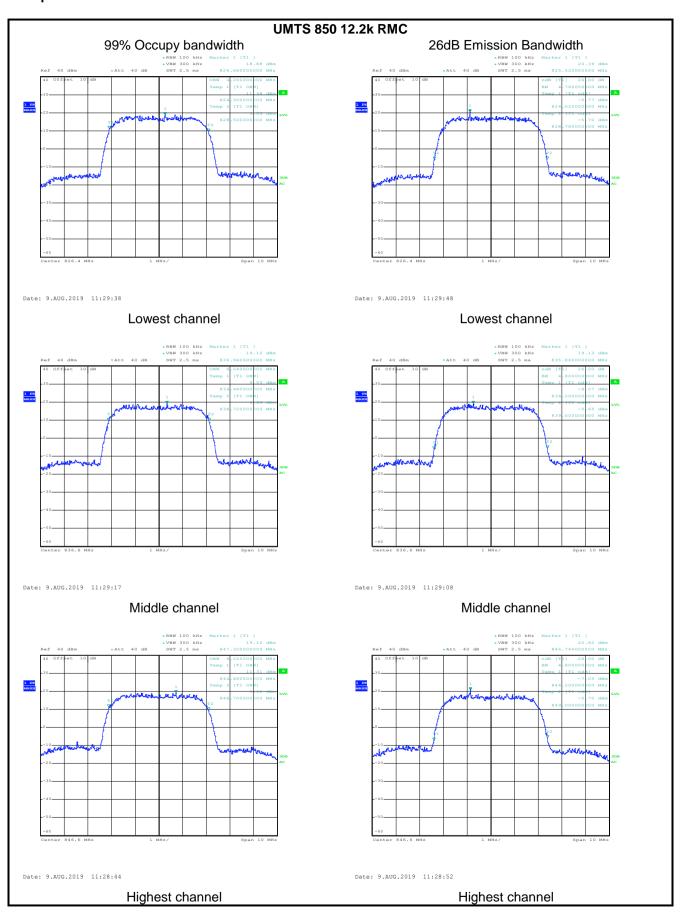
EUT Mode	Channel	Frequency (MHz)	99% Occupy bandwidth (kHz)	-26dB bandwidth (kHz)
LIMTO OFO	4132	826.4	4200	4760
UMTS 850 12.2k RMC	4183	836.6	4240	4800
12.2K KIVIO	4233	846.6	4220	4800
LIMTO 4000	9262	1852.4	4240	4800
UMTS 1900 12.2k RMC	9400	1880.0	4220	4760
12.2K KIVIO	9538	1907.6	4200	4860
LINATO 4700	1312	1712.40	4660	7640
UMTS 1700 12.2k RMC	1413	1732.60	4220	4780
12.2K KIVIC	1513	1752.60	4460	5280

Note:

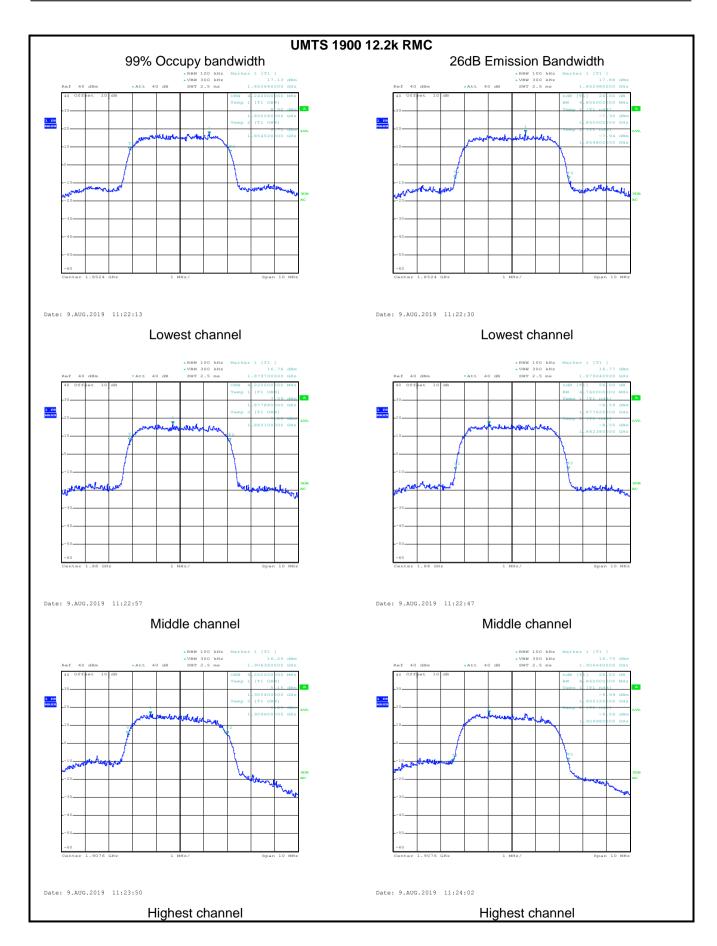
GSM & GPRS use the same modulation technical (GMSK), and with the same channels, so the 99% OBW and the -26dB of GPRS not performed.



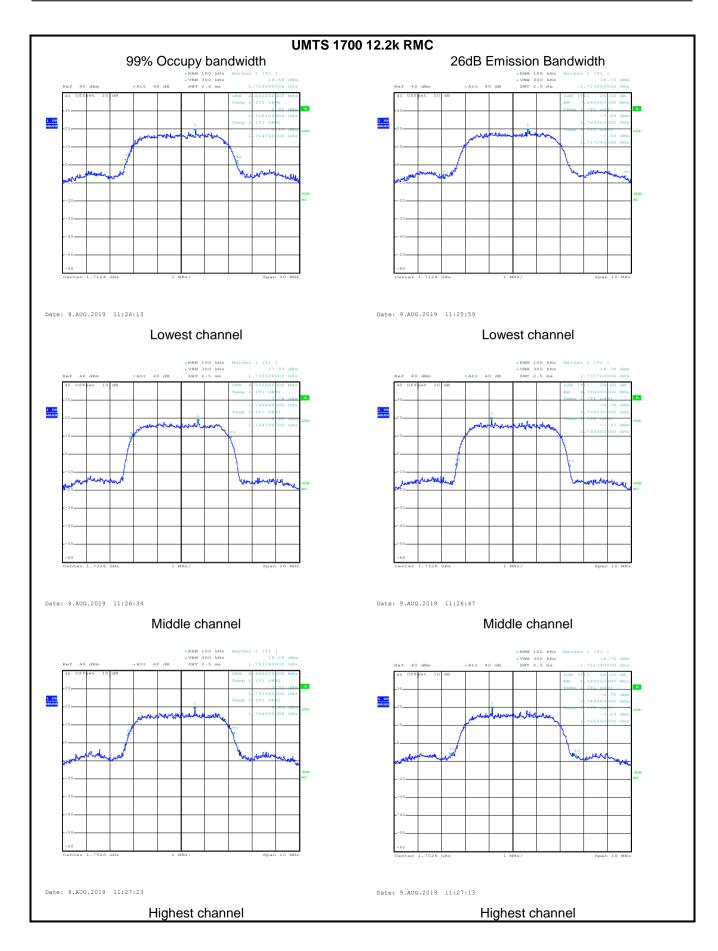
### Test plot as follows:













### 6.4 Modulation Characteristic

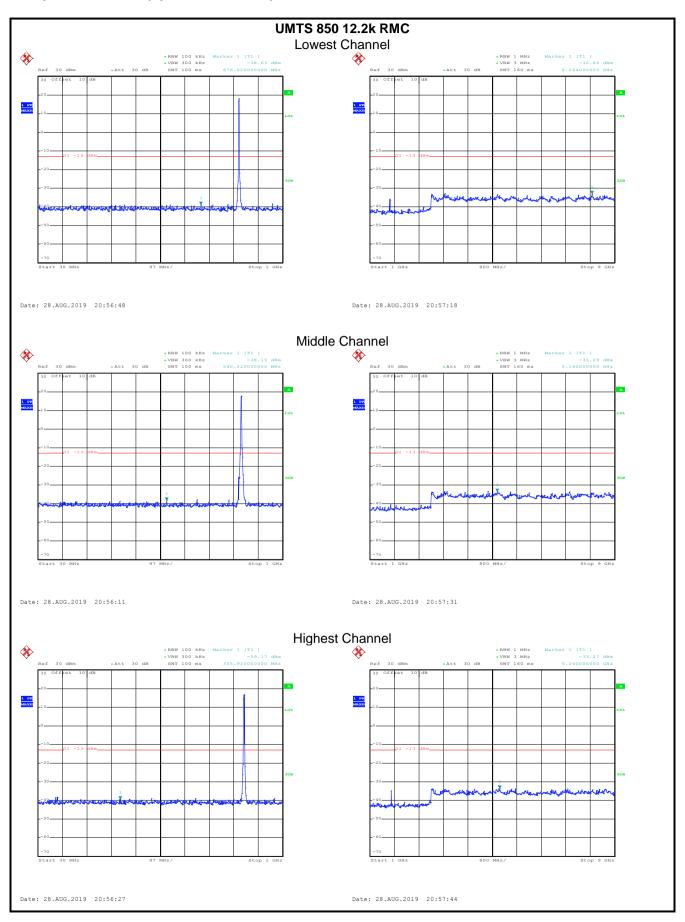
According to FCC § 2.1047(d), Part 22H & 24E & 27L there is no specific requirement for digital modulation, therefore modulation characteristic is not presented.

### 6.5 Out of band emission at antenna terminals

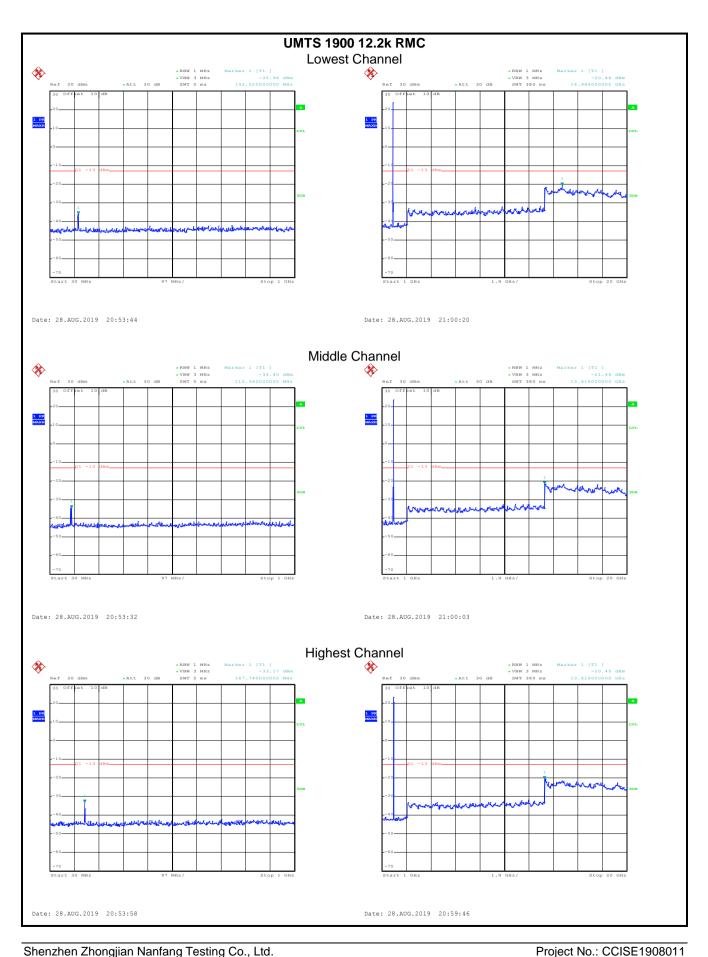
Test Requirement:	FCC part 22.917(a), FCC part 24.238(a), FCC Part 27.53 (h)
Test Method:	ANSI/TIA-603-D 2010
Limit:	-13dBm
Test setup:	System simulator Spectrum Analyzer  Spectrum Analyzer
Test Procedure:	<ol> <li>The RF output of the transceiver was connected to a spectrum analyzer through appropriate attenuation.</li> <li>The resolution bandwidth of the spectrum analyzer was set at 100 kHz when below 1GHz, 1MHz when above 1 GHz; sufficient scans were taken to show the out of band Emissions if any up to 10th harmonic.</li> <li>For the out of band: Set the RBW=100 kHz, VBW=300 kHz when below 1 GHz, RBW =1 MHz, VBW=3 MHz when above 1 GHz, Start=30MHz, Stop= 10th harmonic.</li> <li>Band Edge Requirements: In the 1 MHz bands immediately outside and adjacent to the frequency block, a resolution bandwidth of at least 1 percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to measure the out of band Emissions.</li> </ol>
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed



### Test plots as follows (Spurious emission):





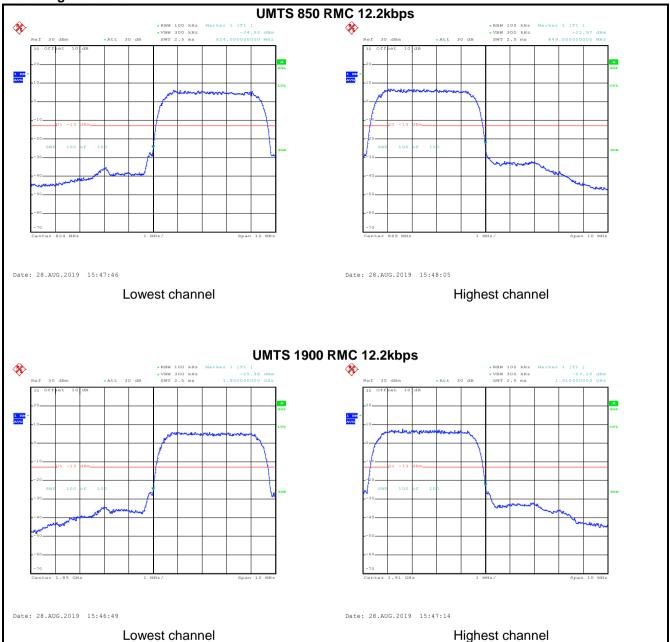




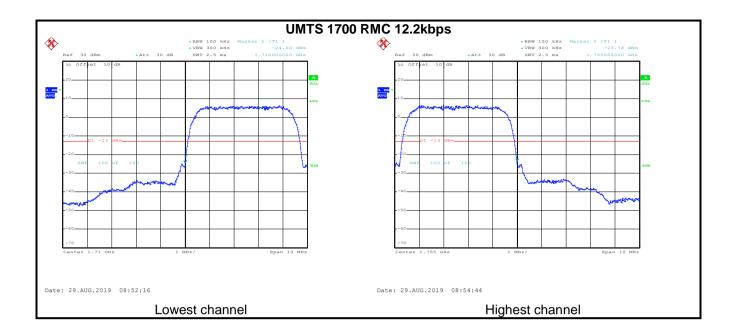




### Band edge emission:









## 6.6 Field strength of spurious radiation measurement

Test Requirement:	FCC part 22.917(a), FCC part 24.238(a), FCC part 27.53(h)
Test Method:	ANSI/TIA-603-D 2010
Limit:	-13dBm
Test setup:	Below 1GHz  Antenna Tower  Ground Reference Plane Signal Generator Power Amplifier  Above 1GHz
	Artenna Tower  Ground Reference Plane  Test Receiver  Amplifer  Controller
Test Procedure:	<ol> <li>The EUT was placed on an non-conductive turntable using a non-conductive support. The radiated emission at the fundamental frequency was measured at 3 m with a test antenna and EMI spectrum analyzer.</li> <li>During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.</li> <li>The frequency range up to tenth harmonic was investigated for each of three fundamental frequency (low, middle and high channels). Once spurious emission was identified, the power of the emission was determined using the substitution method.</li> <li>The spurious emissions attenuation was calculated as the difference between radiated power at the fundamental frequency and the spurious emissions frequency.         ERP / EIRP = S.G. output (dBm) + Antenna Gain(dB/dBi) – Cable Loss (dB)     </li> </ol>
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details.
Test results:	Passed





### Measurement Data (worst case):

		Lowest channel		
(\( \lambda \) \( \lambda \)	Spurious	Emission	Live it (dDas)	Danielt
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
1652.80	Vertical	-55.00	40.00	-
2479.20	V	-51.52	-13.00	Pass
1652.80	Horizontal	-47.12	-13.00	Door
2479.20	Н	-49.73	-13.00	Pass
		Middle channel		
Fraguesia (MIII-)	Spurious	Emission	Livesit (dDves)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	
1673.20	Vertical	-53.63	-13.00	Pass
2509.80	V	-52.47	-13.00	
1673.20	Horizontal	-46.63	-13.00	Pass
2509.80	Н	-49.17	-13.00	
		Highest channel		
Frequency (MHz)	Spurious	Emission	Limit (dRm)	Possile
Frequency (MITZ)	Polarization	Level (dBm)	Limit (dBm)	Result
1693.20	Vertical	-51.43	-13.00	Page
2539.80	V	-53.76	-13.00	Pass
1693.20	Horizontal	-46.51	-13.00	Door
2539.80	Н	-50.75	-13.00	Pass

<sup>1.</sup> The emission levels of below 1 GHz are very lower than the limit and not show in test report.



WCDMA Band II 12.2k RMC					
	Lowest channel				
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result	
Frequency (Miriz)	Polarization	Level (dBm)	Limit (dbin)	Result	
3704.80	Vertical	-45.25	-13.00	Pass	
5557.20	V	-43.82	-13.00	Pass	
3704.80	Horizontal	-37.95	-13.00	Door	
5557.20	Н	-40.85	-13.00	Pass	
		Middle channel			
Fraguenov (MILIT)	Spurious	Emission	Limit (dDm)	Result	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)		
3760.00	Vertical	-44.32	42.00	Pass	
5640.00	V	-41.65	-13.00		
3760.00	Horizontal	-36.63	12.00	Davis	
5640.00	Н	-40.75	-13.00	Pass	
		Highest channel			
Fraguera (MILIF)	Spurious	Emission	Limeit (dDme)	Result	
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)		
3815.20	Vertical	-45.25	40.00	D	
5722.80	V	-42.77	-13.00	Pass	
3815.20	Horizontal	-37.46	42.00	Door	
5722.80	Н	-40.22	-13.00	Pass	
Remark:					

### Remark:

<sup>1.</sup> The emission levels of below 1 GHz are very lower than the limit and not show in test report.



WCDMA Band IV 12.2k RMC				
		Lowest channel		
Frequency (MHz)	Spurious	Emission	Limit (dBm)	Result
Frequency (MITZ)	Polarization	Level (dBm)	Limit (dbin)	Kesuit
3424.40	Vertical	-40.28	-13.00	D
5136.60	V	-42.23	-13.00	Pass
3424.40	Horizontal	-37.61	42.00	Dees
5136.60	Н	-36.69	-13.00	Pass
		Middle channel		
Fraguenay (MHz)	Spurious	Emission	Limit (dDm)	Result
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	
3464.80	Vertical	-39.64	42.00	Pass
5197.20	V	-41.75	-13.00	
3464.80	Horizontal	-36.63	42.00	Dana
5197.20	Н	-35.47	-13.00	Pass
		Highest channel		
[	Spurious	Emission	Lineit (dDae)	Danilt
Frequency (MHz)	Polarization	Level (dBm)	Limit (dBm)	Result
3505.20	Vertical	-40.25	40.00	_
5257.80	V	-42.79	-13.00	Pass
3505.20	Horizontal	-37.43	-13.00	Dese
5257.80	Н	-36.19		Pass
Remark:		•	•	

### Remark:

The emission levels of below 1 GHz are very lower than the limit and not show in test report.



## 6.7 Frequency stability V.S. Temperature measurement

Test Requirement:	FCC Part 22.355, FCC Part 24.235, FCC Part 27.54, FCC Part 2.1055(a)(1)(b)
Test Method:	ANSI/TIA-6-3-D 2010
Limit:	±2.5 ppm for WCDMA 850 Within authorized band for WCDMA 1900 and WCDMA1700
Test setup:	SS EUT  Divider  Temperature & Humidity Chamber
Test procedure:	<ol> <li>The equipment under test was connected to an external DC power supply and input rated voltage.</li> <li>RF output was connected to a frequency counter or spectrum analyzer via feed through attenuators.</li> <li>The EUT was placed inside the temperature chamber.</li> <li>Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and measure EUT 25°C operating frequency as reference frequency.</li> <li>Turn EUT off and set the chamber temperature to -30°C. After the temperature stabilized for approximately 30 minutes recorded the frequency.</li> <li>Repeat step measure with 10°C increased per stage until the highest temperature of +50°C reached</li> </ol>
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





### Measurement Data (the worst channel):

Reference Fre	quency: WCDMA BAI	ND V 12.2k RI	MC Middle channe	l=4183 channel=8	36.6MHz
Power supplied (Vdc)	Temperature (°C)	Freq	uency error	Limit (ppm)	Recult
	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
3.70	-30	178	0.212766		
	-20	161	0.192446		
	-10	150	0.179297		
	0	143	0.170930		Pass
	10	135	0.161367	±2.5	
	20	127	0.151805		
	30	116	0.138656	1	
	40	154	0.184078		
	50	110	0.131485		
Reference Fre	quency: WCDMA BA	ND II 12.2k RI	MC Middle channe	l=9400 channel=1	880MHz
Power supplied	Temperature (°C)	Freq	Frequency error		Descrit
(Vdc)	remperature (C)	Hz	ppm	Limit (ppm)	Result
	-30	189	0.100532		Pass
	-20	173	0.092021	Within authorized band for WCDMA	
	-10	164	0.087234		
	0	157	0.083511		
3.70	10	146	0.077660		
	20	137	0.072872		
	30	128	0.068085		
	40	116	0.061702		
	50	130	0.069149		
Reference F	requency: UMTS170	12.2k RMC I	Middle channel=14	113 channel=1732.	6MHz
Power supplied	Towns and the (%)	Frequency error		Limett (m )	Desult
(Vdc)	Temperature (°C)	Hz	ppm	Limit (ppm)	Result
3.70	-30	175	0.101004	Within authorized	
	-20	159	0.091770		Pass
	-10	147	0.084844		
	0	130	0.075032		
	10	105	0.060603	band for	
	20	126	0.072723	WCDMA	
	30	168	0.096964	1700	
	40	150	0.086575		
	50	121	0.069837		
Jote: Only the worst ca	se shown in the report.			1	



## 6.8 Frequency stability V.S. Voltage measurement

Test Requirement:	FCC Part 22.355, FCC Part 24.235, FCC Part 27.54, FCC Part 2.1055(d)(2)
Test Method:	ANSI/TIA-603-D 2010
Limit:	±2.5ppm
Test setup:	SS EUT  Divider  Temperature & Humidity Chamber  Power Source
Test procedure:	<ol> <li>Set chamber temperature to 25°C. Use a variable DC power source to power the EUT and set the voltage to rated voltage.</li> <li>Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.</li> <li>Reduce the input voltage to specify extreme voltage variation (+/-15%) and endpoint, record the maximum frequency change.</li> </ol>
Test Instruments:	Refer to section 5.8 for details
Test mode:	Refer to section 5.3 for details
Test results:	Passed





### Measurement Data (the worst channel):

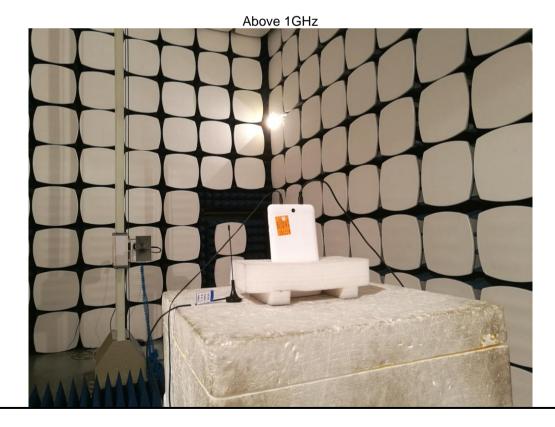
Reference Frequency: UMTS 850 12.2k RMC Middle channel=4183 channel=836.6MHz							
Temperature (℃)	Power supplied (Vdc)	Freq	uency error	Limit (none)	Result		
		Hz	ppm	Limit (ppm)			
25	4.20	90	0.107578	±2.5	Pass		
	3.70	81	0.096820				
	3.50	70	0.083672				
Reference Frequency: UMTS 1900 12.2k RMC Middle channel=9400 channel=1880MHz							
Temperature (°ℂ)	Power supplied	Frequency error		Limit (mana)	Desuit		
	(Vdc)	Hz	ppm	Limit (ppm)	Result		
25	4.20	80	0.042553	- Within authorized band for WCDMA	Pass		
	3.70	72	0.038298				
	3.50	60	0.031915	1900			
Reference Frequency: UMTS1700 12.2k RMC Middle channel=1413 channel=1732.6MHz							
Temperature (°C)	Power supplied	Freq	uency error	Limit (ppm)	Result		
	(Vdc)	Hz	ppm				
25	4.20	88	0.050791	Within authorized band for WCDMA	Pass		
	3.70	68	0.039247				
	3.50	52	0.030013	1700			
Note: Only the worst ca	se shown in the report.						





7 Test Setup Photo

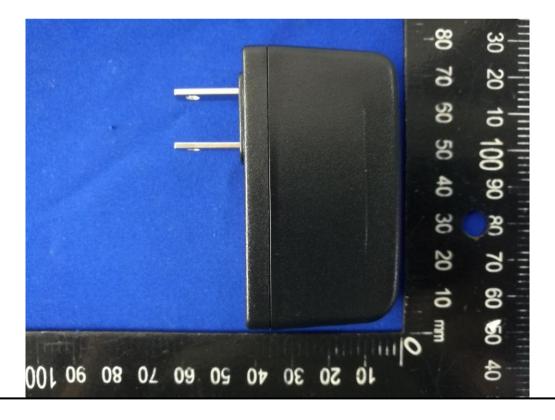




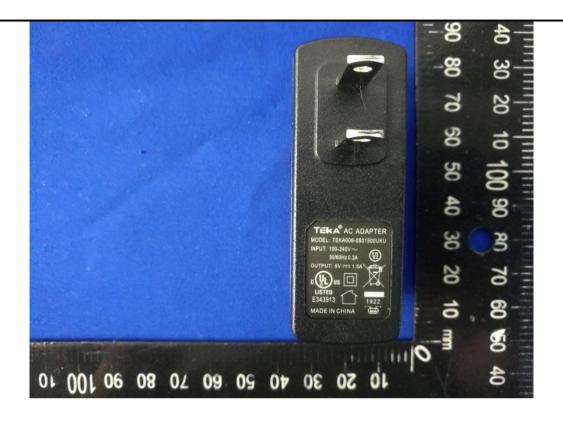


## 8 EUT Constructional Details





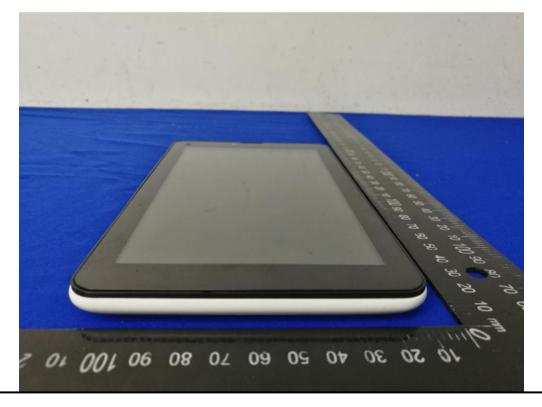








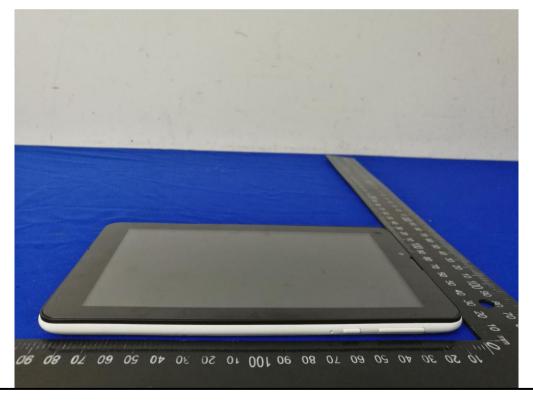












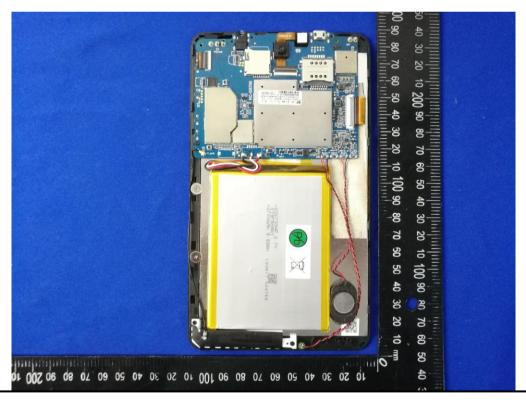






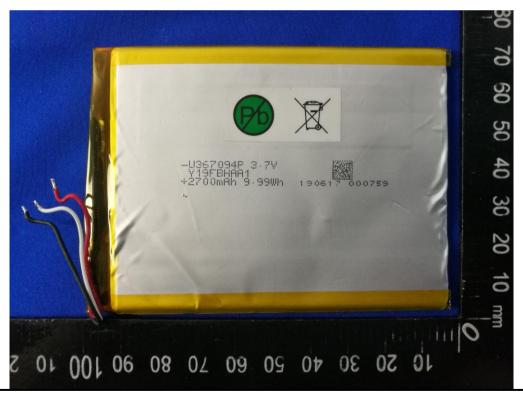




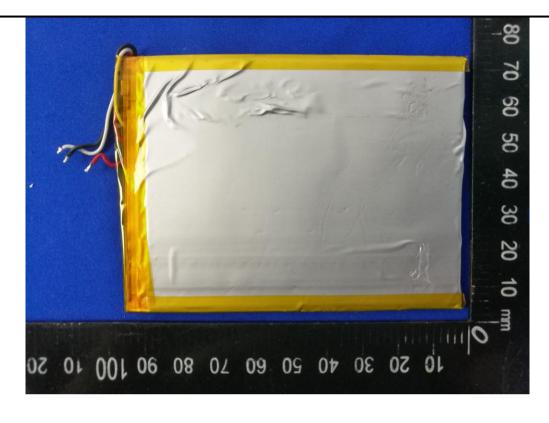






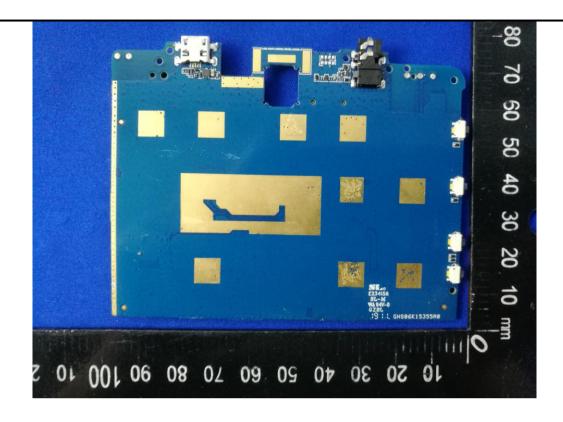






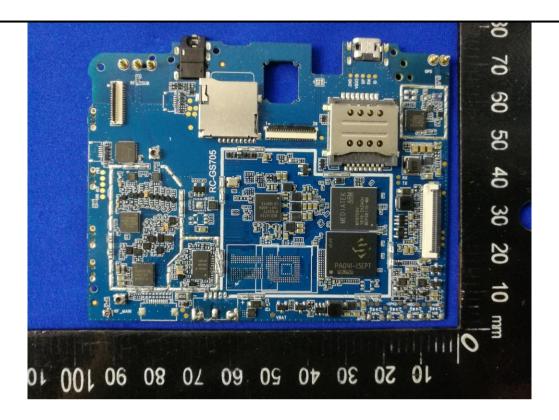




















-----End of report-----